



FCC TEST REPORT

Test report

On Behalf of

SWAGTEK.

For

2.4 inch 3G Flip Phone

Model No.: LOGIC F8G, iSWAG FLIP G, UNONU U8G, UNONU F8G

FCC ID: O55242518

Prepared for : SWAGTEK
10205 NW 19th Street, STE 101, Miami, FL 33172

Prepared By : Shenzhen HUAKE Testing Technology Co., Ltd.
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Date of Test: July 24, 2018~Aug. 22, 2018

Date of Report: Oct. 11, 2018

Report Number: HUAKE180803685E



TEST RESULT CERTIFICATION

Applicant's name : SWAGTEK
Address : 10205 NW 19th Street, STE 101, Miami, FL 33172
Manufacture's Name..... : SWAGTEK
Address : 10205 NW 19th Street, STE 101, Miami, FL 33172
Product description : 2.4 inch 3G Flip Phone
Brand Name : LOGIC, iSWAG, UNONU
Mode Name : LOGIC F8G, iSWAG FLIP G, UNONU U8G, UNONU F8G
Difference Description : a) All the same except for brand name and model name, the corresponding relationship are as follow:
b) **LOGIC** is corresponding **LOGIC F8G**;
iSWAG is corresponding **iSWAG FLIP G**;
UNONU is corresponding **UNONU U8G**;
UNONU is corresponding **UNONU F8G**
Standards : FCC Rules and Regulations Part 15 Subpart C Section 15.247
ANSI C63.10: 2013

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Date of Test :
Date (s) of performance of tests : July 24, 2018~Aug. 22, 2018
Date of Issue..... : Oct. 11, 2018
Test Result..... : **Pass**

Testing Engineer : 

(Gary Qian)

Technical Manager : 

(Eden Hu)

Authorized Signatory : 

(Jason Zhou)



Revision	Issue Date	Revisions	Revised By
V1.0	Aug. 23, 2018	Initial Issue	Jason Zhou
V1.1	Oct. 11, 2018	Revise Report	Jason Zhou



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1. TEST SUMMARY

1.1. PRODUCT DESCRIPTION

Equipment	2.4 inch 3G Flip Phone
Model Name	LOGIC F8G
Hardware Version	sc7701_barphone
Software Version	LOGIC_F8G_CLARO_PE_V4.0_31072018
Serial No.	iSWAG FLIP G, UNONU U8G, UNONU F8G
Model Difference	a) All the same except for brand name and model name, the corresponding relationship are as follow: b) LOGIC is corresponding LOGIC F8G ; ISWAG is corresponding ISWAG FLIP G ; UNONU is corresponding UNONU U8G, UNONU F8G
FCC ID	O55242518
Antenna Type	Monopole Antenna
Antenna Gain	1.0dBi
BT Operation frequency	2402-2480MHz
Number of Channels	79(For BR/EDR)
Modulation Type	GFSK
Power Supply	DC3.7V



1.2. TABLE OF CARRIER FREQUENCIES

Frequency Band	Channel Number	Frequency
2400~2483.5MHZ	0	2402MHZ
	1	2403MHZ
	:	:
	38	2440 MHZ
	39	2441 MHZ
	40	2442 MHZ
	:	:
	77	2479 MHZ
	78	2480 MHZ



1.3. RECEIVER INPUT BANDWIDTH

The input bandwidth of the receiver is 1.3MHz. In every connection one Bluetooth device is the master and the other one is slave. The master determines the hopping sequence. The slave follows this sequence. Both devices shift between RX and TX time slot according to the clock of the master. Additionally the type of connection (e.g. single or multislotted packet) is set up at the beginning of the connection. The master adapts its hopping frequency and its TX/RX timing according to the packet type of the connection. Also the slave of the connection will use these settings.

Repeating of a packet has no influence on the hopping sequence. The hopping sequence generated by the master of the connection will be followed in any case. That means, a repeated packet will not be sent on the same frequency, it is sent on the next frequency of the hopping sequence.

1.4. EXAMPLE OF A HOPPING SEQUENCE IN DATA MODE

Example of a 79 hopping sequence in data mode:

40,21,44,23,42,53,46,55,48,33,52,35,50,65,54,67
56,37,60,39,58,69,62,71,64,25,68,27,66,57,70,59
72,29,76,31,74,61,78,63,01,41,05,43,03,73,07,75
09,45,13,47,11,77,15,00,64,49,66,53,68,02,70,06
01, 51, 03, 55, 05, 04

1.5. EQUALLY AVERAGE USE OF FREQUENCIES AND BEHAVIOUR

The generation of the hopping sequence in connection mode depends essentially on two input values:

1. LAP/UAP of the master of the connection.
2. Internal master clock

The LAP (lower address part) are the 24 LSB's of the 48 BD_ADDRESS. The BD_ADDRESS is an unambiguous number of every Bluetooth unit. The UAP (upper address part) are the 24 MSB's of the 48BD_ADDRESS

The internal clock of a Bluetooth unit is derived from a free running clock which is never adjusted and is never turned off. For synchronization with other units only offsets are used. It has no relation to the time of the day. Its resolution is at least half the RX/TX slot length of 312.5µs. The clock has a cycle of about one day (23h30). In most cases it is implemented as 28 bit counter. For the deriving of the hopping sequence the entire LAP (24 bits), 4 LSB's (4 bits) (Input 1) and the 27 MSB's of the clock (Input 2) are used. With these input values different mathematical procedures (permutations, additions, XOR-operations) are performed to generate the Sequence. This will be done at the beginning of every new transmission.

Regarding short transmissions the Bluetooth system has the following behavior:

The first connection between the two devices is established, a hopping sequence was generated. For transmitting the wanted data the complete hopping sequence was not used. The connection ended.

The second connection will be established. A new hopping sequence is generated. Due to the fact the Bluetooth clock has a different value, because the period between the two transmissions is longer (and it cannot be shorter) than the minimum resolution of the clock (312.5µs). The hopping sequence will always differ from the first one.



1.6. RELATED SUBMITTAL(S) / GRANT (S)

This submittal(s) (test report) is intended for **FCC ID: O55242518** filing to comply with Section 15.247 of the FCC Part 15, Subpart C Rules.

1.7. TEST METHODOLOGY

Both conducted and radiated testing was performed according to the procedures in ANSI C63.10 (2013). Radiated testing was performed at an antenna to EUT distance 3 meters.

1.8. SPECIAL ACCESSORIES

Refer to section 5.2.

1.9. EQUIPMENT MODIFICATIONS

Not available for this EUT intended for grant.



2. MEASUREMENT UNCERTAINTY

Test	Measurement Uncertainty	Notes
Transmitter power conducted	± 0.57 dB	(1)
Transmitter power Radiated	± 2.20 dB	(1)
Conducted spurious emission 9KHz-40 GHz	± 2.20 dB	(1)
Occupied Bandwidth	± 0.01 ppm	(1)
Radiated Emission 30~1000MHz	± 4.10 dB	(1)
Radiated Emission Above 1GHz	± 4.32 dB	(1)
Conducted Disturbance 0.15~30MHz	± 3.20 dB	(1)

Note: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.



3. DESCRIPTION OF TEST MODES

NO.	TEST MODE DESCRIPTION
1	Low channel GFSK
2	Middle channel GFSK
3	High channel GFSK
4	Normal Hopping

Note:

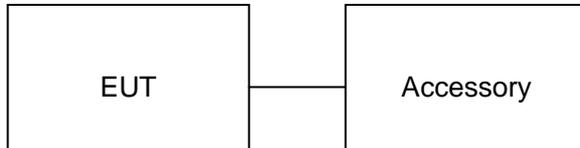
1. All the test modes can be supply by Built-in Li-ion battery and the test data recorded in the report.
2. For Radiated Emission, 3axis were chosen for testing for each applicable mode.



4. SYSTEM TEST CONFIGURATION

4.1. CONFIGURATION OF EUT SYSTEM

Configuration:



4.2. EQUIPMENT USED IN EUT SYSTEM

Item	Equipment	Model No.	ID or Specification	Remark
1	2.4 inch 3G Flip Phone	LOGIC F8G	O55242518	EUT
2	Adapter	F8G	DC 5.0V 500mA	Accessory
3	Battery	F8G	DC 3.7V/800mAh	Accessory

4.3. SUMMARY OF TEST RESULTS

FCC RULES	DESCRIPTION OF TEST	RESULT
§15.247	Peak Output Power	Compliant
§15.247	20 dB Bandwidth	Compliant
§15.247	Spurious Emission	Compliant
§15.209	Radiated Emission	Compliant
§15.247	Band Edges	Compliant
§15.207	Power Line Conduction Emission	Compliant
§15.247	Number of Hopping Frequency	Compliant
§15.247	Time of Occupancy	Compliant
§15.247	Frequency Separation	Compliant



5. TEST FACILITY

Site	Shenzhen HUAKE Testing Technology Co., Ltd.
Location	1F, B2 Building, Junfeng Zhongcheng Zhizao Innovation Park, Fuhai Street, Bao'an District, Shenzhen City, China
Designation Number	CN1229
Test Firm Registration Number : 616276	

ALL TEST EQUIPMENT LIST

RF Test Room				
Equipment	Manufacturer	Model	Serial Number	Calibration Due
Power meter	Agilent	E4417B	HKE-107	Dec. 28, 2018
Power Sensor	Agilent	E9327A	HKE-113	Dec. 28, 2018
RF cable	Times	1-40G	HKE-034	Dec. 28, 2018
RF automatic control unit	Tonscend	JS0806-2	HKE-060	Dec. 28, 2018
Spectrum analyzer	Agilent	N9020A	HKE-048	Dec. 28, 2018
RF Cable (9KHz-26.5GHz)	Tonscend	170660	N/A	Dec. 28, 2018
Signal generator	Agilent	N5183A	HKE-071	Dec. 28, 2018
Receiver	R&S	ESCI-7	HKE-010	Dec. 28, 2018
Spectrum analyzer	Agilent	N9020A	HKE-048	Dec. 28, 2018
Preamplifier	EMCI	EMC051845SE	HKE-015	Dec. 28, 2018
Preamplifier	Agilent	83051A	HKE-016	Dec. 28, 2018
Loop antenna	Schwarzbeck	FMZB 1519 B	HKE-014	Dec. 28, 2018
Broadband antenna	Schwarzbeck	VULB 9163	HKE-012	Dec. 28, 2018
Horn antenna	Schwarzbeck	9120D	HKE-013	Dec. 28, 2018
Antenna Mast	Keleto	CC-A-4M	N/A	N/A
Position controller	Taiwan MF	MF7802	HKE-011	Dec. 28, 2018
Radiated test software	Tonscend	TS+ Rev 2.5.0.0	HKE-082	N/A
RF cable (9KHz-1GHz)	Times	381806-001	N/A	N/A
RF cable	Times	1-40G	HKE-034	Dec. 28, 2018



6. PEAK OUTPUT POWER

6.1. MEASUREMENT PROCEDURE

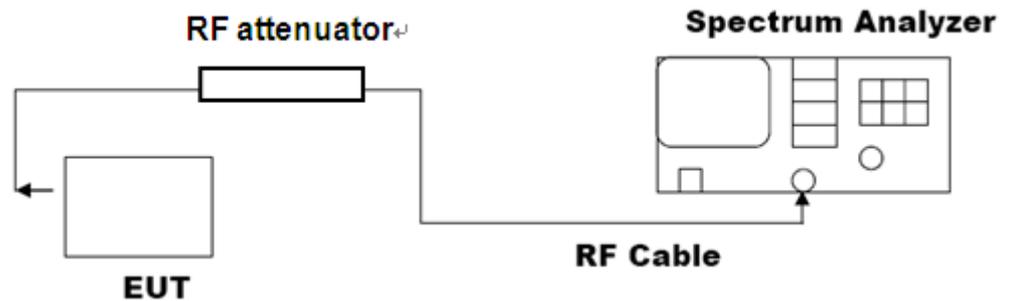
For peak power test:

1. Connect EUT RF output port to the Spectrum Analyzer through an RF attenuator
2. Set the EUT Work on the top, middle and the bottom operation frequency individually.
3. Use the following spectrum analyzer settings:
 - 1) Span : Approximately five times the 20 dB bandwidth, centered on a hopping channel.
 - 2) RBW > 20 dB bandwidth of the emission being measured.
 - 3) VBW \geq RBW.
 - 4) Sweep: Auto.
 - 5) Detector function: Peak.
 - 6) Trace: Max hold.
4. Record the maximum power from the Spectrum Analyzer.

Note : The EUT was tested according for compliance ANSI C63.10 (2013) requirements.

6.2. TEST SET-UP (BLOCK DIAGRAM OF CONFIGURATION)

PEAK POWER TEST SETUP

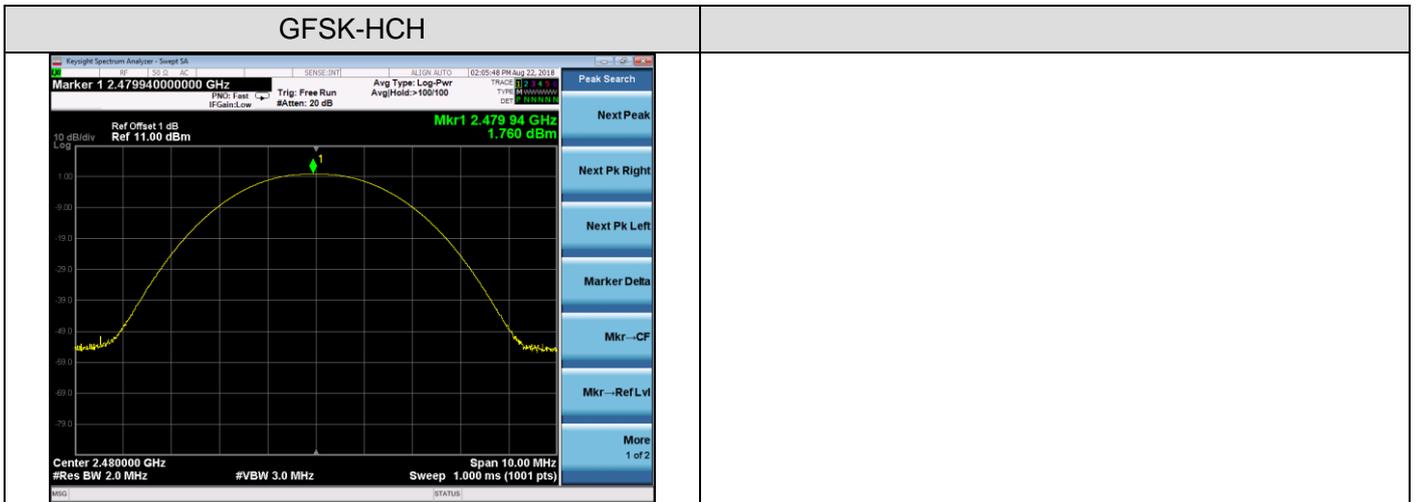
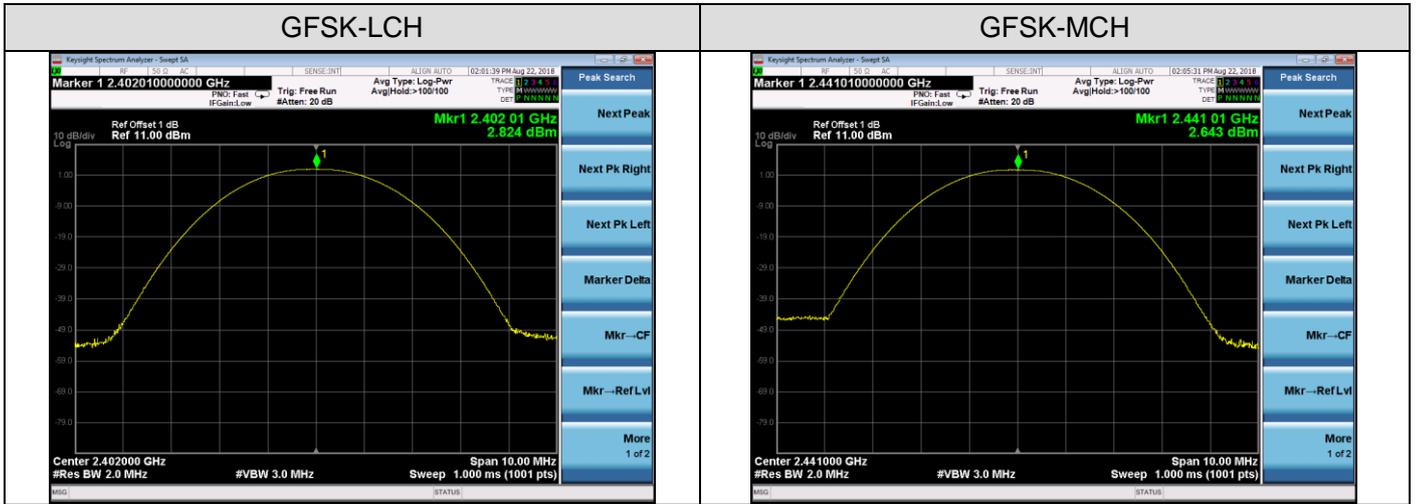


**6.3. LIMITS AND MEASUREMENT RESULT**

Mode	Frequency (GHz)	Peak Power (dBm)	Applicable Limits (dBm)	Pass or Fail
GFSK	2.402	2.824	30	Pass
	2.441	2.643	30	Pass
	2.480	1.760	30	Pass



Test Graph

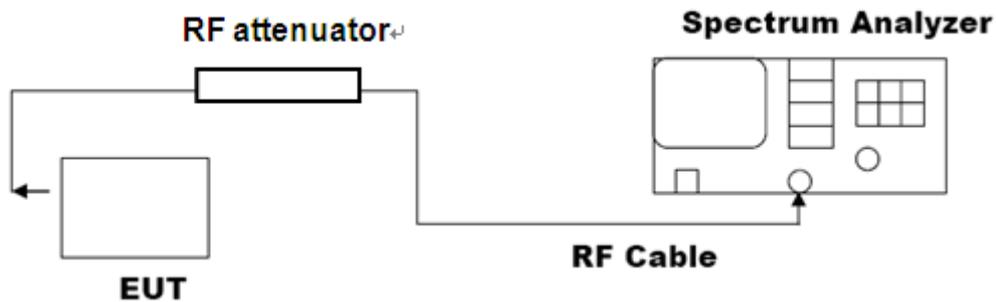


7. 20DB BANDWIDTH

7.1. MEASUREMENT PROCEDURE

1. Connect EUT RF output port to the Spectrum Analyzer through an RF attenuator
2. Set the EUT Work on the top, the middle and the bottom operation frequency individually.
3. Set Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hoping channel
 $RBW \geq 1\%$ of the 20 dB bandwidth, $VBW \geq RBW$; Sweep = auto; Detector function = peak
4. Set SPA Trace 1 Max hold, then View.

7.2. TEST SET-UP (BLOCK DIAGRAM OF CONFIGURATION)

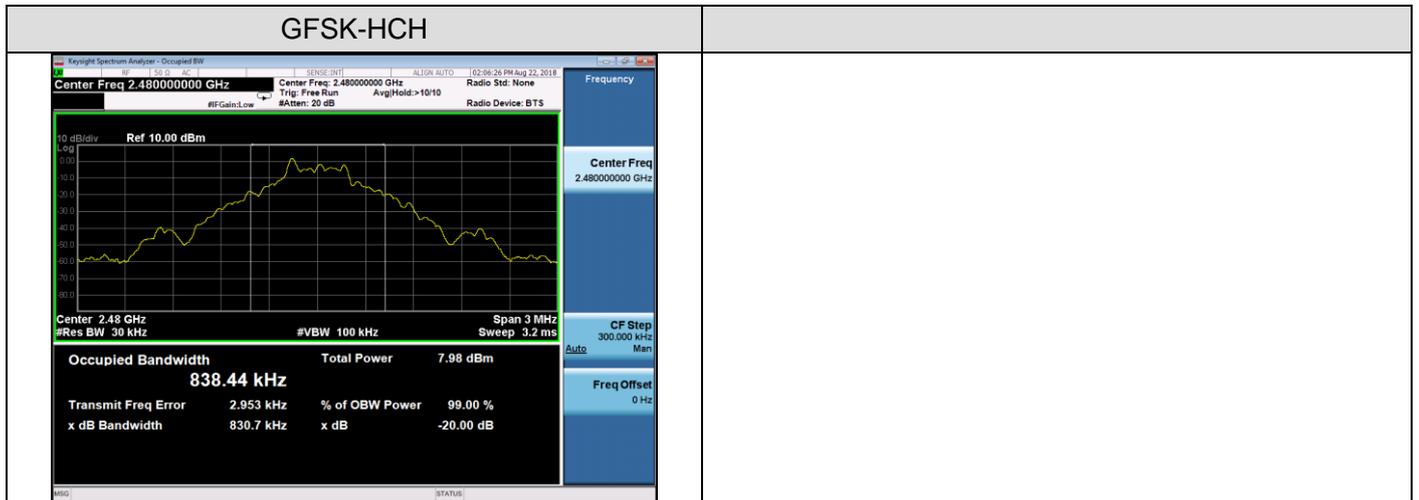


7.3. LIMITS AND MEASUREMENT RESULTS

Mode	Channel.	20dB Bandwidth [KHz]	Verdict
GFSK	LCH	830.1	PASS
GFSK	MCH	830.3	PASS
GFSK	HCH	830.7	PASS



Test Graph





8. CONDUCTED SPURIOUS EMISSION

8.1. MEASUREMENT PROCEDURE

1. Connect EUT RF output port to the Spectrum Analyzer through an RF attenuator
2. Set the EUT Work on the top, the Middle and the bottom operation frequency individually.
3. Set the Span = wide enough to capture the peak level of the in-band emission and all spurious emissions from the lowest frequency generated in the EUT up through the 10th harmonic.
RBW = 100 kHz; VBW \geq RBW; Sweep = auto; Detector function = peak.
4. Set SPA Trace 1 Max hold, then View.

Note: The EUT was tested according for compliance ANSI C63.10 (2013) requirements. Owing to satisfy the requirements of the number of measurement points, we set the RBW=1MHz, VBW $>$ RBW, scan up through 10th harmonic, and consider the tested results as the worst case, if the tested results conform to the requirement, we can deem that the real tested results(set the RBW=100KHz, VBW $>$ RBW) are conform to the requirement.

8.2. TEST SET-UP (BLOCK DIAGRAM OF CONFIGURATION)

The same as described in section 8.2



8.3. MEASUREMENT EQUIPMENT USED

The same as described in section 6

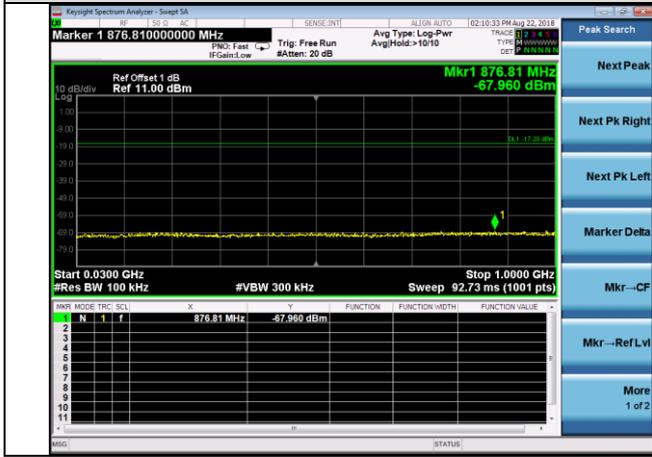
8.4. LIMITS AND MEASUREMENT RESULT

LIMITS AND MEASUREMENT RESULT		
Applicable Limits	Measurement Result	
	Test Data	Criteria
In any 100 KHz Bandwidth Outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produce by the intentional radiator shall be at least 20 dB below that in 100KHz bandwidth within the band that contains the highest level of the desired power. In addition, radiation emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in§15.209(a))	At least -20dBc than the limit Specified on the BOTTOM Channel	PASS
	At least -20dBc than the limit Specified on the TOP Channel	PASS

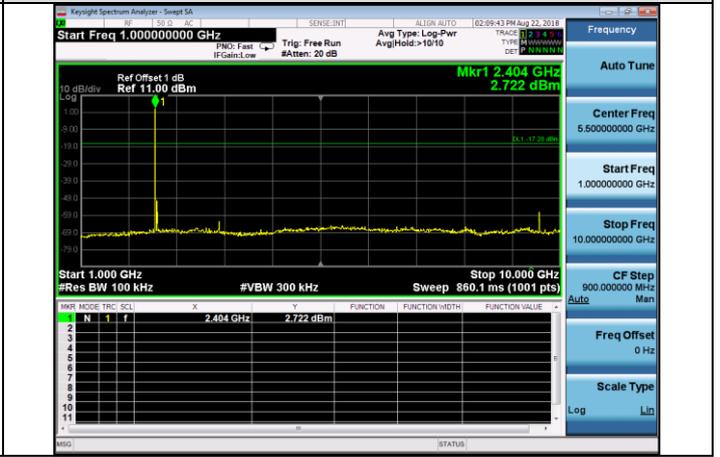


Test Graph

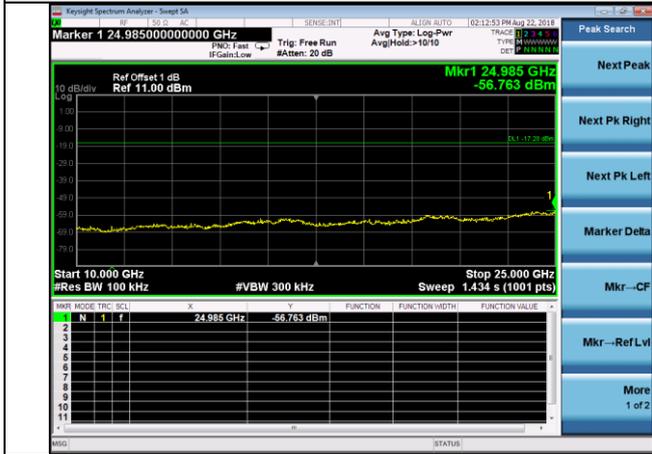
GFSK-LCH



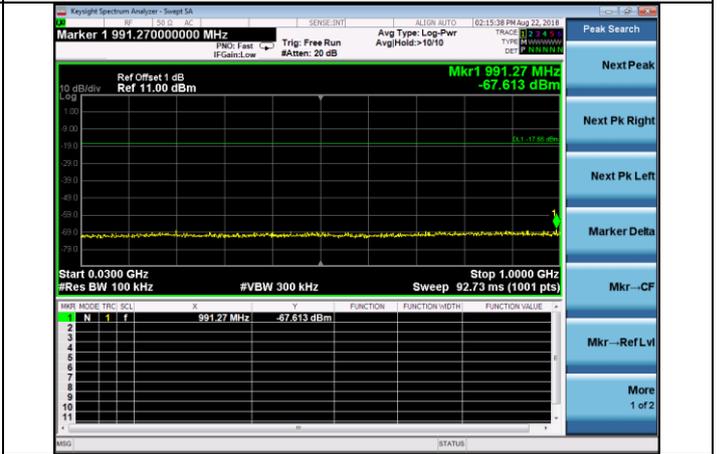
GFSK-LCH



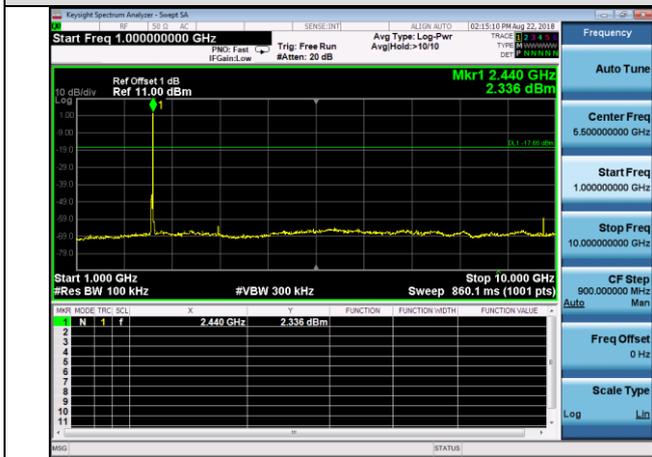
GFSK-LCH



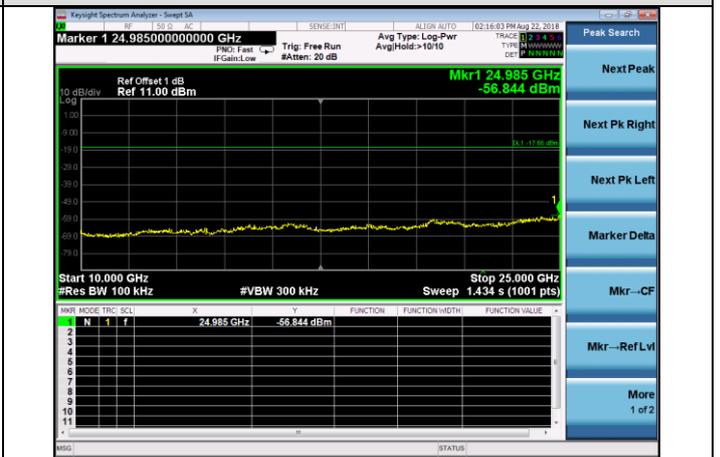
GFSK-MCH



GFSK-MCH



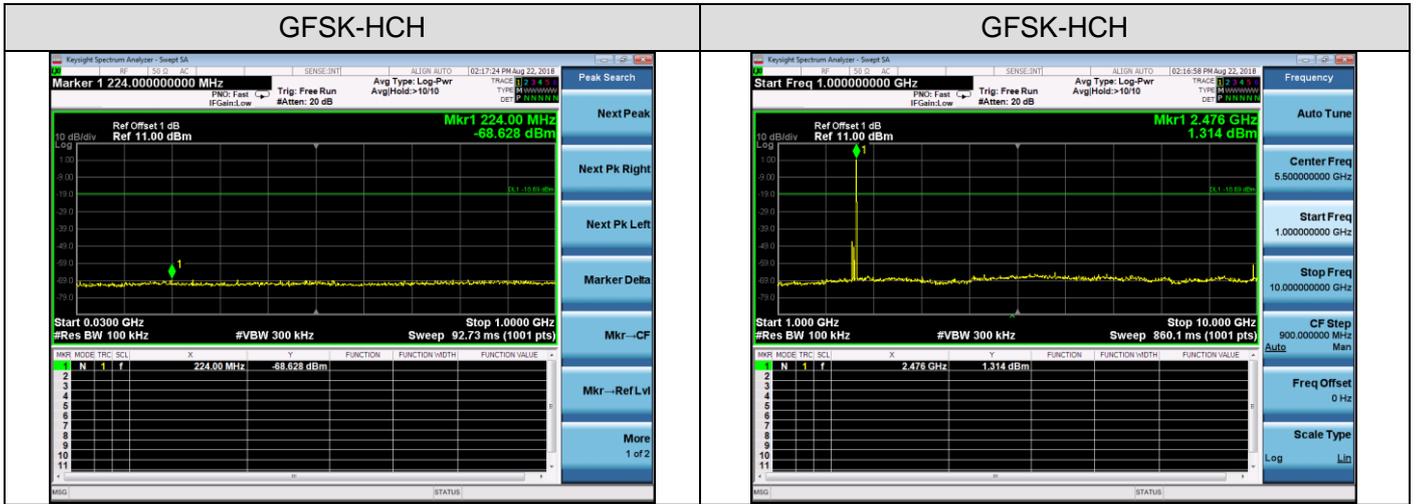
GFSK-MCH



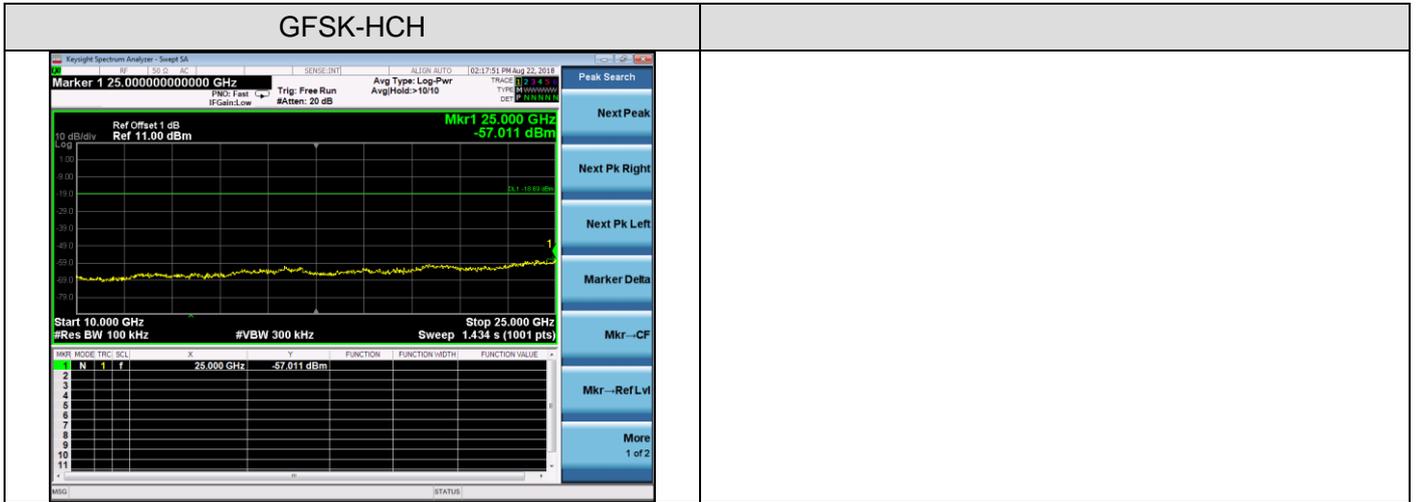


GFSK-HCH

GFSK-HCH



GFSK-HCH





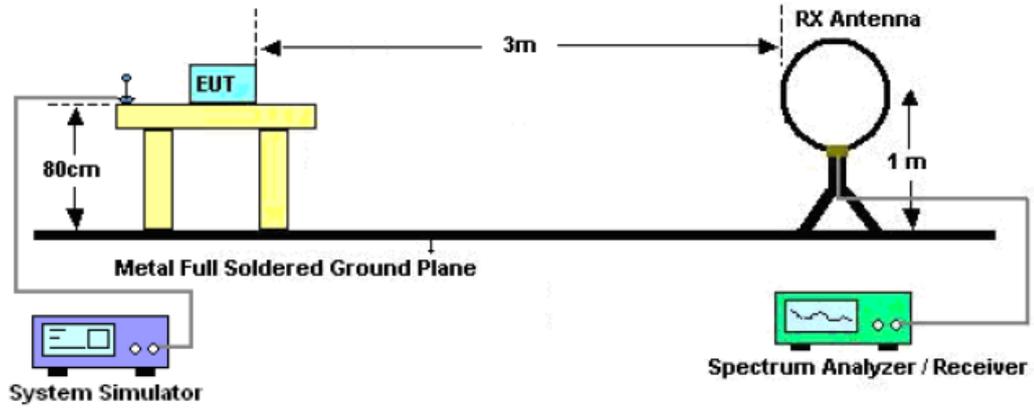
9. RADIATED EMISSION

9.1. MEASUREMENT PROCEDURE

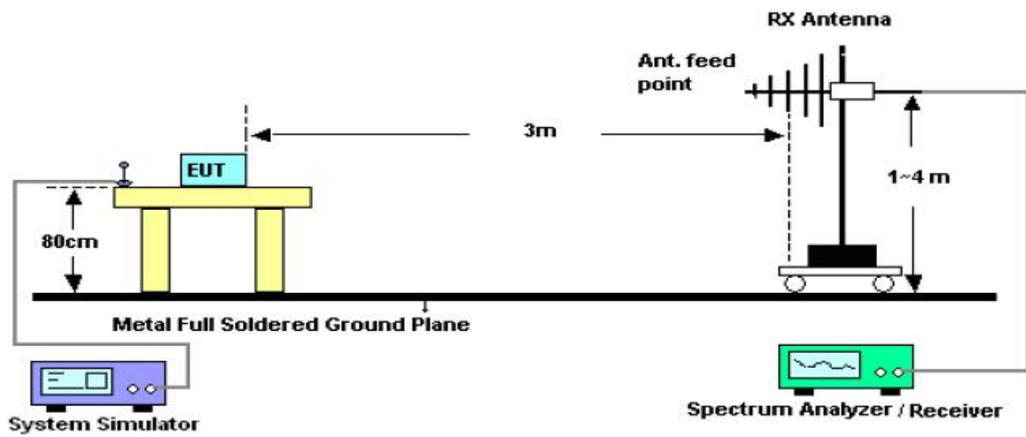
1. The EUT was placed on the top of the turntable 0.8 or 1.5 meter above ground. The phase center of the receiving antenna mounted on the top of a height-variable antenna tower was placed 3 meters far away from the turntable.
2. Power on the EUT and all the supporting units. The turntable was rotated by 360 degrees to determine the position of the highest radiation.
3. The height of the broadband receiving antenna was varied between one meter and four meters above ground to find the maximum emissions field strength of both horizontal and vertical polarization.
4. For each suspected emissions, the antenna tower was scan (from 1 M to 4 M) and then the turntable was rotated (from 0 degree to 360 degrees) to find the maximum reading.
5. Set the test-receiver system to Peak or CISPR quasi-peak Detect Function with specified bandwidth under Maximum Hold Mode.
6. For emissions above 1GHz, use 1MHz VBW and RBW for peak reading. Then 1MHz RBW and 10Hz VBW for average reading in spectrum analyzer. Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.
7. When the radiated emissions limits are expressed in terms of the average value of the emissions, and pulsed operation is employed, the measurement field strength shall be determined by averaging over one complete pulse train, including blanking intervals, as long as the pulse train does not exceed 0.1 seconds. As an alternative (provided the transmitter operates for longer than 0.1 seconds) or in cases where the pulse train exceeds 0.1 seconds, the measured field strength shall be determined from the average absolute voltage during a 0.1 second interval during which the field strength is at its maximum values.
8. If the emissions level of the EUT in peak mode was 3 dB lower than the average limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 3 dB margin will be repeated one by one using the quasi-peak method for below 1GHz.
9. For testing above 1GHz, the emissions level of the EUT in peak mode was lower than average limit (that means the emissions level in peak mode also complies with the limit in average mode), then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions will be measured in average mode again and reported.
10. In case the emission is lower than 30MHz, loop antenna has to be used for measurement and the recorded data should be QP measured by receiver. High - Low scan is not required in this case.

9.2. TEST SETUP

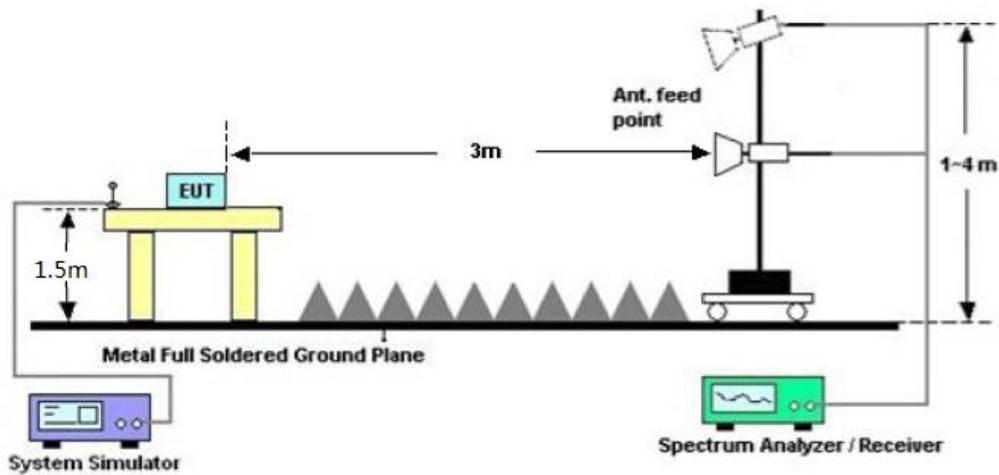
RADIATED EMISSION TEST-SETUP FREQUENCY BELOW 30MHZ



RADIATED EMISSION TEST SETUP 30MHz-1000MHz



RADIATED EMISSION TEST SETUP ABOVE 1000MHz





9.3. LIMITS AND MEASUREMENT RESULT

15.209(a) Limit in the below table has to be followed

Frequencies (MHz)	Field Strength (micorvolts/meter)	Measurement Distance (meters)
0.009~0.490	2400/F(KHz)	300
0.490~1.705	24000/F(KHz)	30
1.705~30.0	30	30
30~88	100	3
88~216	150	3
216~960	200	3
Above 960	500	3



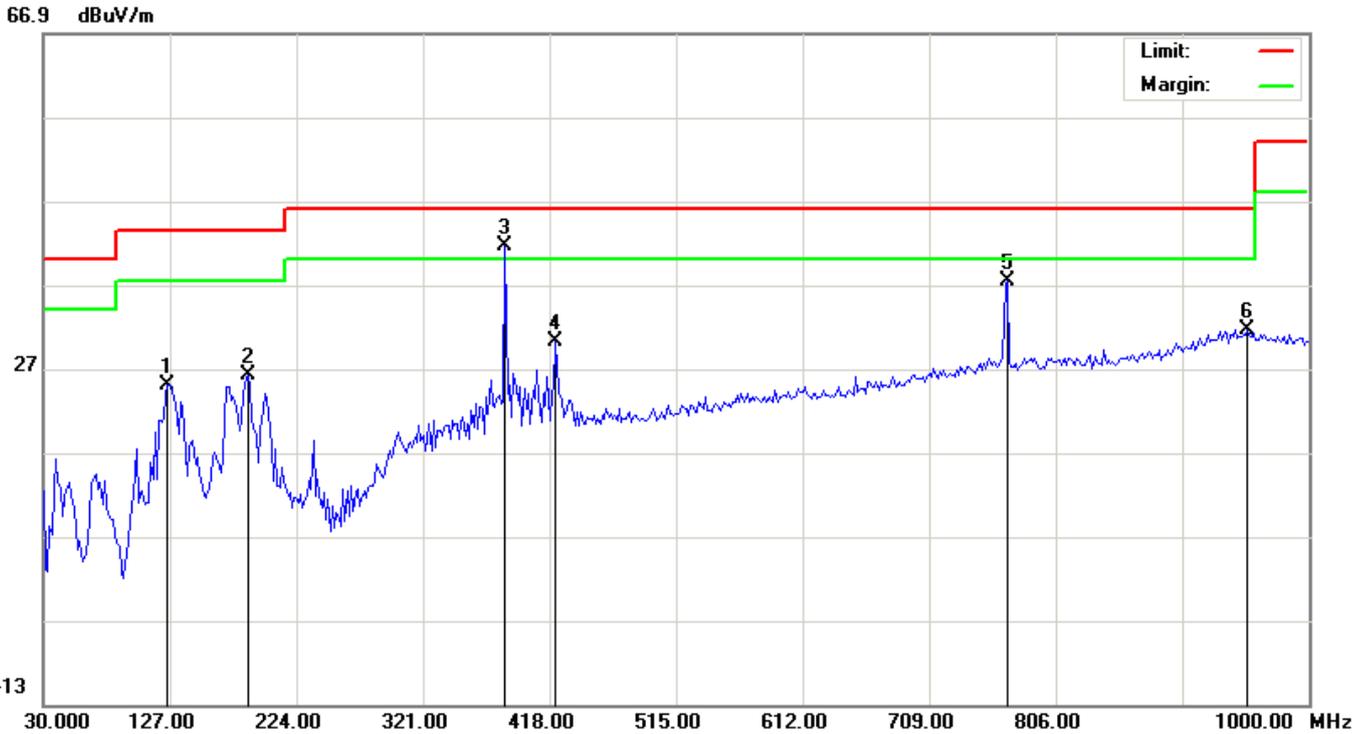
9.4. TEST RESULT

RADIATED EMISSION BELOW 30MHZ

No emission found between lowest internal used/generated frequencies to 30MHz.

RADIATED EMISSION BELOW 1GHZ

RADIATED EMISSION TEST- (30MHZ-1GHZ) -HORIZONTAL



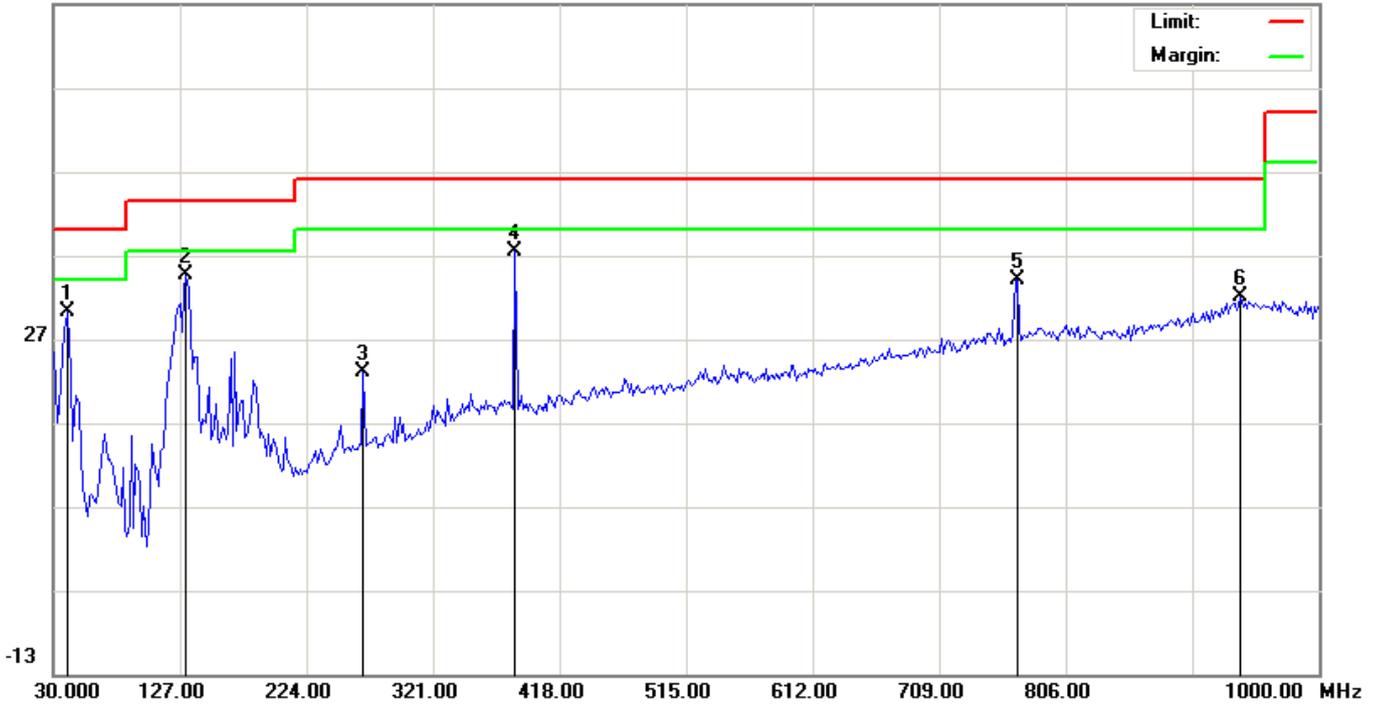
No.	Mk	Freq.	Reading	Factor	Measurement	Limit	Over	Detector	Antenna Height	Table Degree	Comment
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		cm	degree	
1		125.3833	16.68	8.37	25.05	43.50	-18.45	peak			
2		186.8167	14.88	11.39	26.27	43.50	-17.23	peak			
3	*	384.0500	22.58	18.96	41.54	46.00	-4.46	peak			
4		422.8500	10.47	19.76	30.23	46.00	-15.77	peak			
5		768.8167	10.44	26.89	37.33	46.00	-8.67	peak			
6		953.1167	1.72	29.97	31.69	46.00	-14.31	peak			

RESULT: PASS



RADIATED EMISSION TEST- (30MHZ-1GHZ) -VERTICAL

66.9 dBuV/m



No.	Mk	Freq.	Reading	Factor	Measurement	Limit	Over	Detector	Antenna Height	Table Degree	Comment
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		cm	degree	
1		41.3167	21.31	8.81	30.12	40.00	-9.88	peak			
2		131.8500	22.82	11.80	34.62	43.50	-8.88	peak			
3		267.6500	8.60	14.43	23.03	46.00	-22.97	peak			
4	*	384.0500	18.38	18.96	37.34	46.00	-8.66	peak			
5		768.8167	7.12	26.89	34.01	46.00	-11.99	peak			
6		940.1833	2.21	29.73	31.94	46.00	-14.06	peak			

RESULT: PASS

Note: 1. Factor=Antenna Factor + Cable loss, Margin=Measurement-Limit.

2. The "Factor" value can be calculated automatically by software of measurement system.

3. All test modes for different EUT are pre-tested. The low channel for GFSK mode is the worst case and recorded in the report.



RADIATED EMISSION TEST- (ABOVE 1GHZ)

Frequency (MHz)	Emission Level (dB μ V/m)	Limits (dB μ V/m)	Margin (dB)	Detector Type	Comment
Low Channel (2402 MHz)					
4804	47.54	74	-26.46	Pk	Vertical
4804	38.17	54	-15.83	AV	Vertical
4804	48.56	74	-25.44	Pk	Horizontal
4804	39.31	54	-14.69	AV	Horizontal
Mid Channel (2441 MHz)					
4882	47.57	74	-26.43	Pk	Vertical
4882	38.29	54	-15.71	AV	Vertical
4882	48.85	74	-25.15	Pk	Horizontal
4882	39.19	54	-14.81	AV	Horizontal
High Channel (2480 MHz)					
4960	47.52	74	-26.48	pk	Vertical
4960	38.36	54	-15.64	AV	Vertical
4960	48.89	74	-25.11	pk	Horizontal
4960	39.19	54	-14.81	AV	Horizontal

RESULT: PASS**Note:**

1. 1GHz~25GHz: No recording in the test report at least have 20dB margin)
2. Margin = Emission Level - Limit



10. BAND EDGE EMISSION

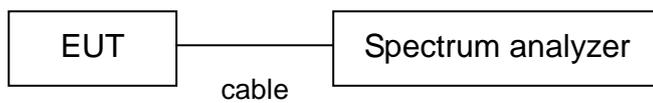
10.1. MEASUREMENT PROCEDURE

1. The transmitter output is connected to a spectrum analyzer. The resolution bandwidth is set to 100kHz. The video bandwidth is set to 300kHz.
2. Transmitter set to the normal hopping mode at 2.4 and 2.4835 GHz.

10.2. TEST SET-UP

Radiated same as 10.2

Conducted set up



**10.3. RADIATED TEST RESULT**

Frequency	Emission Level	Limits	Margin	Detector	Comment
(MHz)	(dB μ V/m)	(dB μ V/m)	(dB)	Type	
GFSK					
2399.9	47.47	74	-26.53	peak	Vertical
2399.9	38.32	54	-15.68	AVG	Vertical
2399.9	48.61	74	-25.39	peak	Horizontal
2399.9	39.29	54	-14.71	AVG	Horizontal
2483.6	48.35	74	-25.65	peak	Vertical
2483.6	35.49	54	-18.51	AVG	Vertical
2483.6	52.84	74	-21.16	peak	Horizontal
2483.6	39.44	54	-14.56	AVG	Horizontal

RESULT: PASS

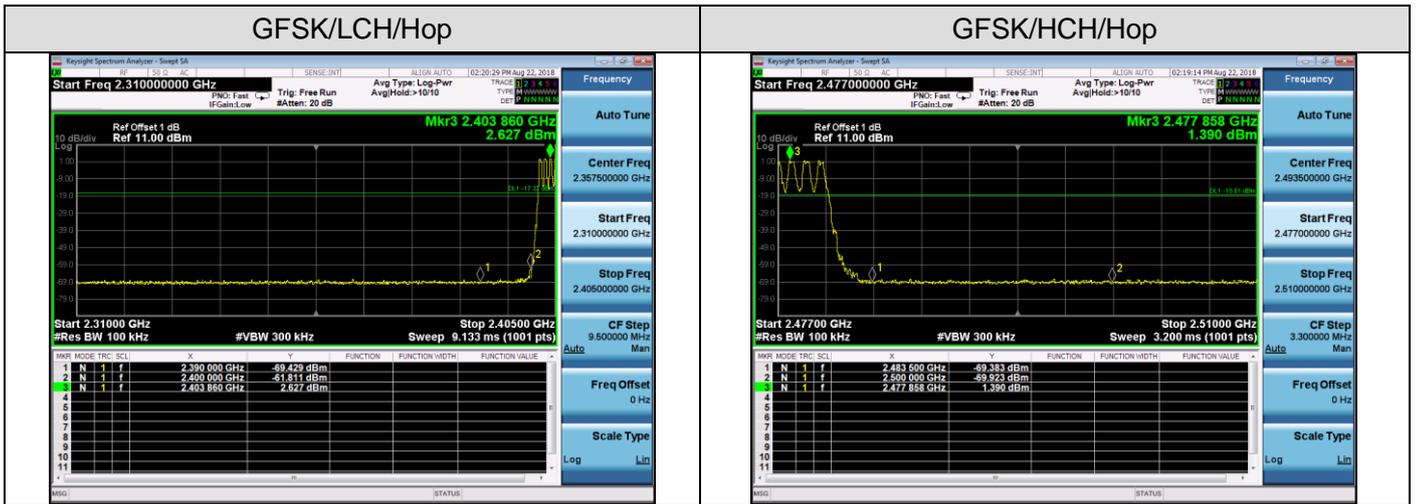
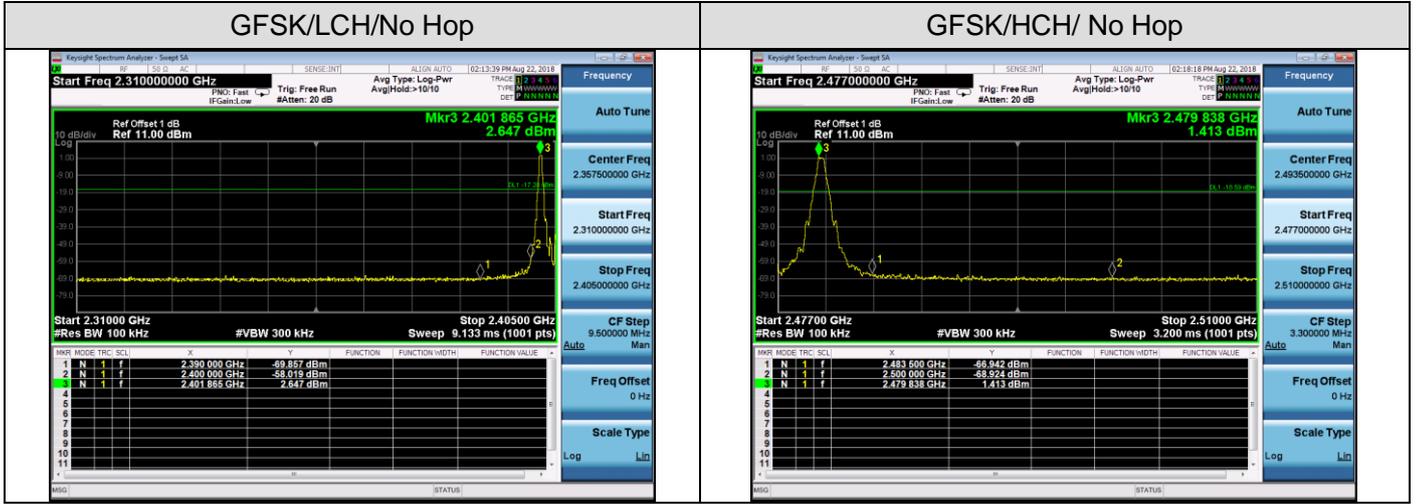
Note: The other modes radiation emission have enough 20dB margin.

$$\text{Margin} = \text{Emission Level} - \text{Limit}$$



10.4 CONDUCTED TEST RESULT

Test Graph





12. TIME OF OCCUPANCY (DWELL TIME)

12.1. MEASUREMENT PROCEDURE

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span: Zero span, centered on a hopping channel.
2. RBW shall be \leq channel spacing and where possible RBW should be set $\gg 1/T$, where T is the expected dwell time per channel.
3. Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel.
4. Detector function: Peak. Trace: Max hold.
5. Use the marker-delta function to determine the transmit time per hop.
6. Using the following equation:

The dwell time is calculated with the following formula:

$$\text{Dwell time} = t_{\text{pulse}} \times n_{\text{hops}} / \text{number of channels} \times 31.6 \text{ s}$$

Where:

t_{pulse} is the measured pulse time (pls. refer the plots of the spectrum analyser above) [s],

n_{hops} is the number of hops per second in the actual operating mode of the transmitter [1/s].

The hopping rate of the system is 1600 hops per second and the system uses 79 channels. For this reason one time slot has a length of 625 μ s.

With the used hopping mode (DH5) a packet need 5 timeslots for transmitting and the next timeslot for receiving. So the system makes in worst case 266,67 hops per second in transmit mode ($n_{\text{hops}} = 266.667$ 1/s)

12.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)

Same as described in section 8.2

12.3. MEASUREMENT EQUIPMENT USED

The same as described in section 6



12.4. LIMITS AND MEASUREMENT RESULT

Channel.	Burst Width [ms/hop/ch]	Dwell Time[ms]	Verdict	Limit (ms)
LCH	3.090	329.6004	PASS	400
MCH	9.090	329.6004	PASS	400
HCH	3.090	329.6004	PASS	400

Test Graph



14. FCC LINE CONDUCTED EMISSION TEST

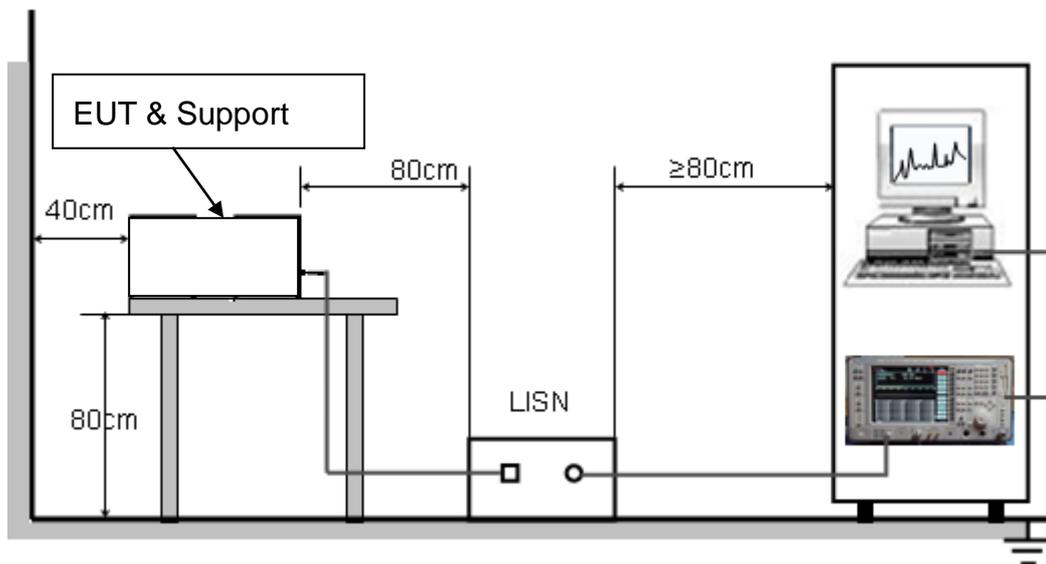
14.1. LIMITS OF LINE CONDUCTED EMISSION TEST

Frequency	Maximum RF Line Voltage	
	Q.P.(dBuV)	Average(dBuV)
150kHz~500kHz	66-56	56-46
500kHz~5MHz	56	46
5MHz~30MHz	60	50

Note:

1. The lower limit shall apply at the transition frequency.
2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz.

14.2. BLOCK DIAGRAM OF LINE CONDUCTED EMISSION TEST





14.3. PRELIMINARY PROCEDURE OF LINE CONDUCTED EMISSION TEST

1. The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.10 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
2. Support equipment, if needed, was placed as per ANSI C63.10.
3. All I/O cables were positioned to simulate typical actual usage as per ANSI C63.10.
4. All support equipments received AC120V/60Hz power from a LISN, if any.
5. The EUT received DC charging voltage by adapter which received 120V/60Hz power by a LISN..
6. The test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
7. Analyzer / Receiver scanned from 150 kHz to 30MHz for emissions in each of the test modes.
8. During the above scans, the emissions were maximized by cable manipulation.
9. The test mode(s) were scanned during the preliminary test.

Then, the EUT configuration and cable configuration of the above highest emission level were recorded for reference of final testing.

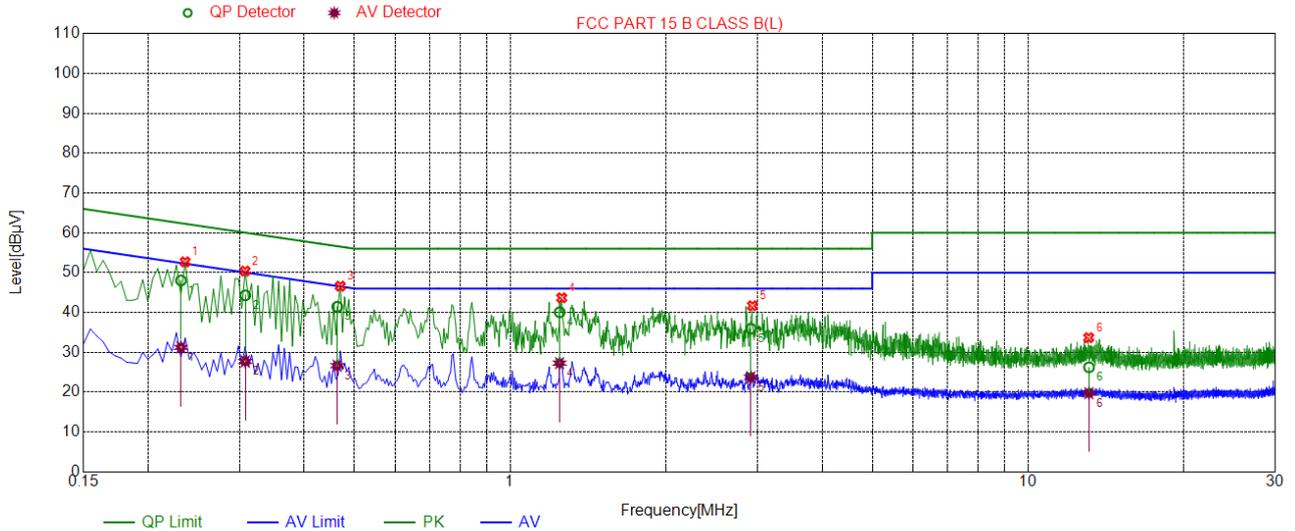
14.4. FINAL PROCEDURE OF LINE CONDUCTED EMISSION TEST

1. EUT and support equipment was set up on the test bench as per step 2 of the preliminary test.
2. A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less -2dB to the A.V. limit in Peak mode, then the emission signal was re-checked using Q.P and Average detector.



14.5. TEST RESULT OF LINE CONDUCTED EMISSION TEST

LINE CONDUCTED EMISSION TEST LINE 1-L



Suspected List

NO.	Freq. [MHz]	Level [dBµV]	Factor [dB]	Limit [dBµV]	Margin [dB]	Detector
1	0.2355	52.70	10.03	62.82	10.12	PK
2	0.3075	50.39	10.05	60.52	10.13	PK
3	0.4695	46.59	10.04	56.60	10.01	PK
4	1.2570	43.67	10.09	56.00	12.33	PK
5	2.9355	41.67	10.21	56.00	14.33	PK
6	13.0965	33.66	9.96	60.00	26.34	PK

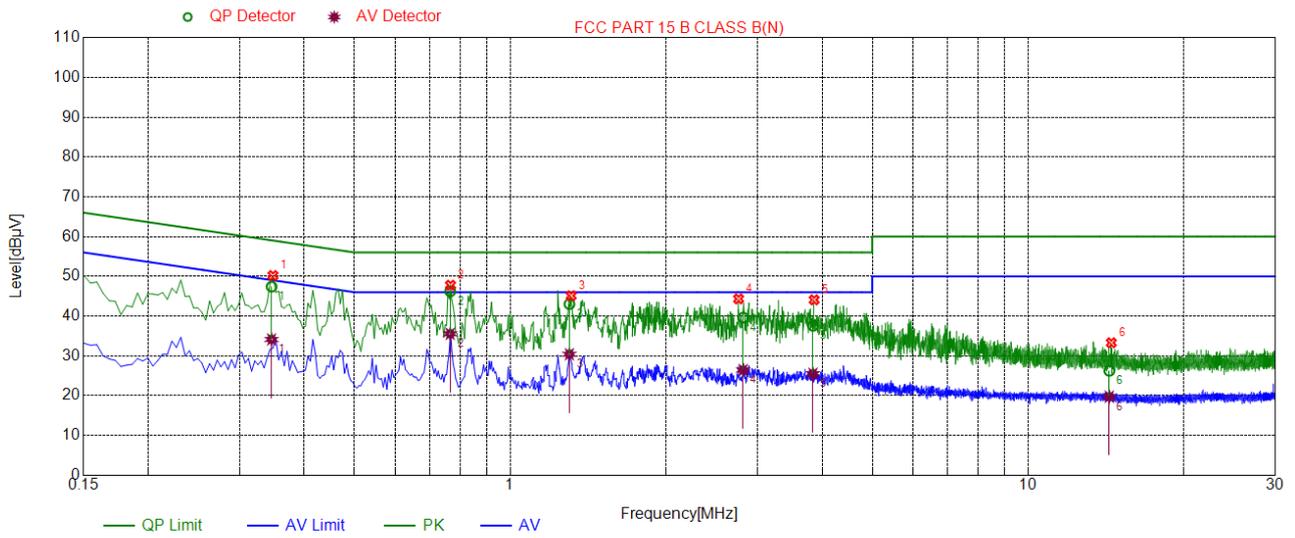
Final Data List

NO.	Freq. [MHz]	Factor [dB]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]
1	0.2311	10.03	48.03	62.41	14.38	31.22	52.41	21.19
2	0.3077	10.05	44.29	60.03	15.74	27.69	50.03	22.34
3	0.4631	10.04	41.43	56.64	15.21	26.63	46.64	20.01

4	1.2451	10.09	40.05	56.00	15.95	27.27	46.00	18.73
5	2.9145	10.21	35.91	56.00	20.09	23.68	46.00	22.32
6	13.1117	9.96	26.22	60.00	33.78	19.72	50.00	30.28



LINE CONDUCTED EMISSION TEST LINE 2-N



Suspected List

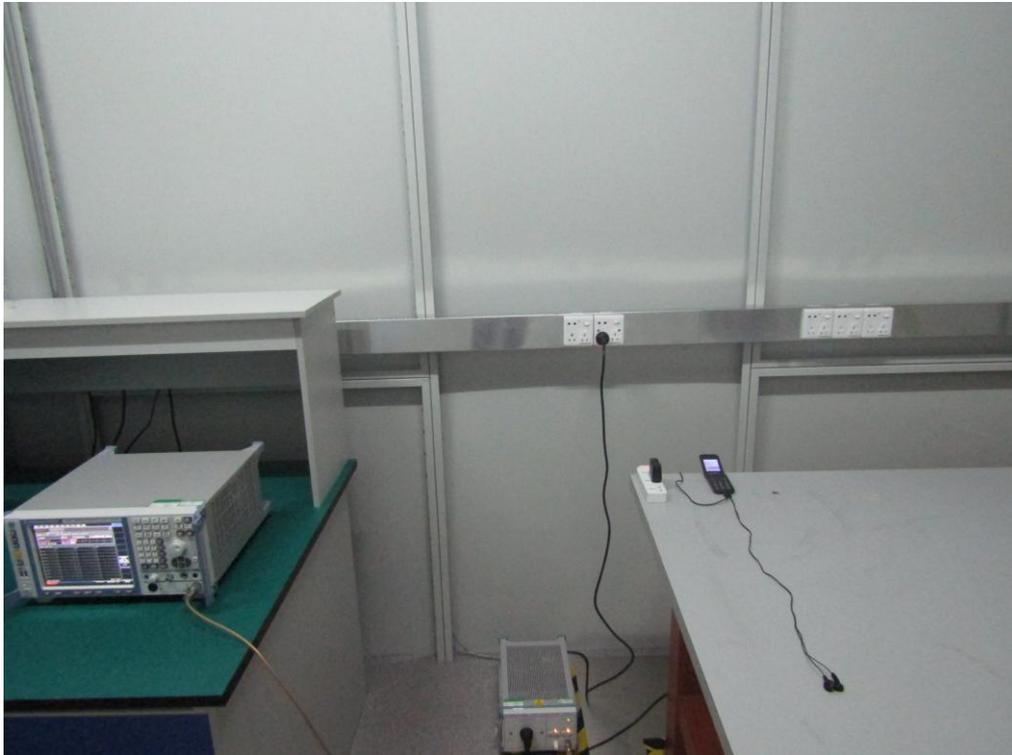
NO.	Freq. [MHz]	Level [dBµV]	Factor [dB]	Limit [dBµV]	Margin [dB]	Detector
1	0.3480	50.20	10.03	59.01	8.81	PK
2	0.7665	47.77	10.05	56.00	8.23	PK
3	1.3110	45.11	10.10	56.00	10.89	PK
4	2.7600	44.31	10.21	56.00	11.69	PK
5	3.8625	44.08	10.25	56.00	11.92	PK
6	14.4825	33.27	9.95	60.00	26.73	PK

Final Data List

NO.	Freq. [MHz]	Factor [dB]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]
1	0.3458	10.03	47.40	59.06	11.66	34.11	49.06	14.95
2	0.7654	10.05	46.22	56.00	9.78	35.52	46.00	10.48
3	1.3006	10.10	43.02	56.00	12.98	30.38	46.00	15.62
4	2.8159	10.21	39.61	56.00	16.39	26.41	46.00	19.59
5	3.8418	10.25	37.53	56.00	18.47	25.47	46.00	20.53
6	14.3504	9.95	26.22	60.00	33.78	19.71	50.00	30.29

APPENDIX A: PHOTOGRAPHS OF TEST SETUP

LINE CONDUCTED EMISSION TEST SETUP



RADIATED EMISSION TEST SETUP





RADIATED EMISSION ABOVE 1G TEST SETUP



----END OF REPORT----